

Notice of References Cited		Application/Control No. 10/584,937	Applicant(s)/Patent Under Reexamination AHN, JOON-YOUNG	
		Examiner KAREEN RUSH	Art Unit 3781	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,226,236 A	12-1965	WELLER BERTHOLD L	53/403
*	B	US-4,034,884 A	07-1977	White, Fred K.	220/8
*	C	US-4,165,003 A	08-1979	Drader, Clarence H.	206/506
*	D	US-5,155,974 A	10-1992	Garwood, Anthony J. M.	53/510
*	E	US-5,192,019 A	03-1993	Meehan, Kermit E.	229/101
*	F	US-5,447,016 A	09-1995	Ueda et al.	53/510
*	G	US-5,465,901 A	11-1995	Paine, Jr., Derrick	229/407
*	H	US-6,039,205 A	03-2000	Flink, Christopher M.	220/659
*	I	US-6,126,067 A	10-2000	Grigsby et al.	229/120
*	J	US-6,237,775 B1	05-2001	Hatch et al.	206/519
*	K	US-6,705,061 B1	03-2004	Porret et al.	53/425
*	L	US-6,786,514 B2	09-2004	Gledhill, Dale C.	283/81
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.